

<IGBT Modules>

# CM500C2Y-24S

**HIGH POWER SWITCHING USE  
INSULATED TYPE**



**dual pack (Emitter common)**

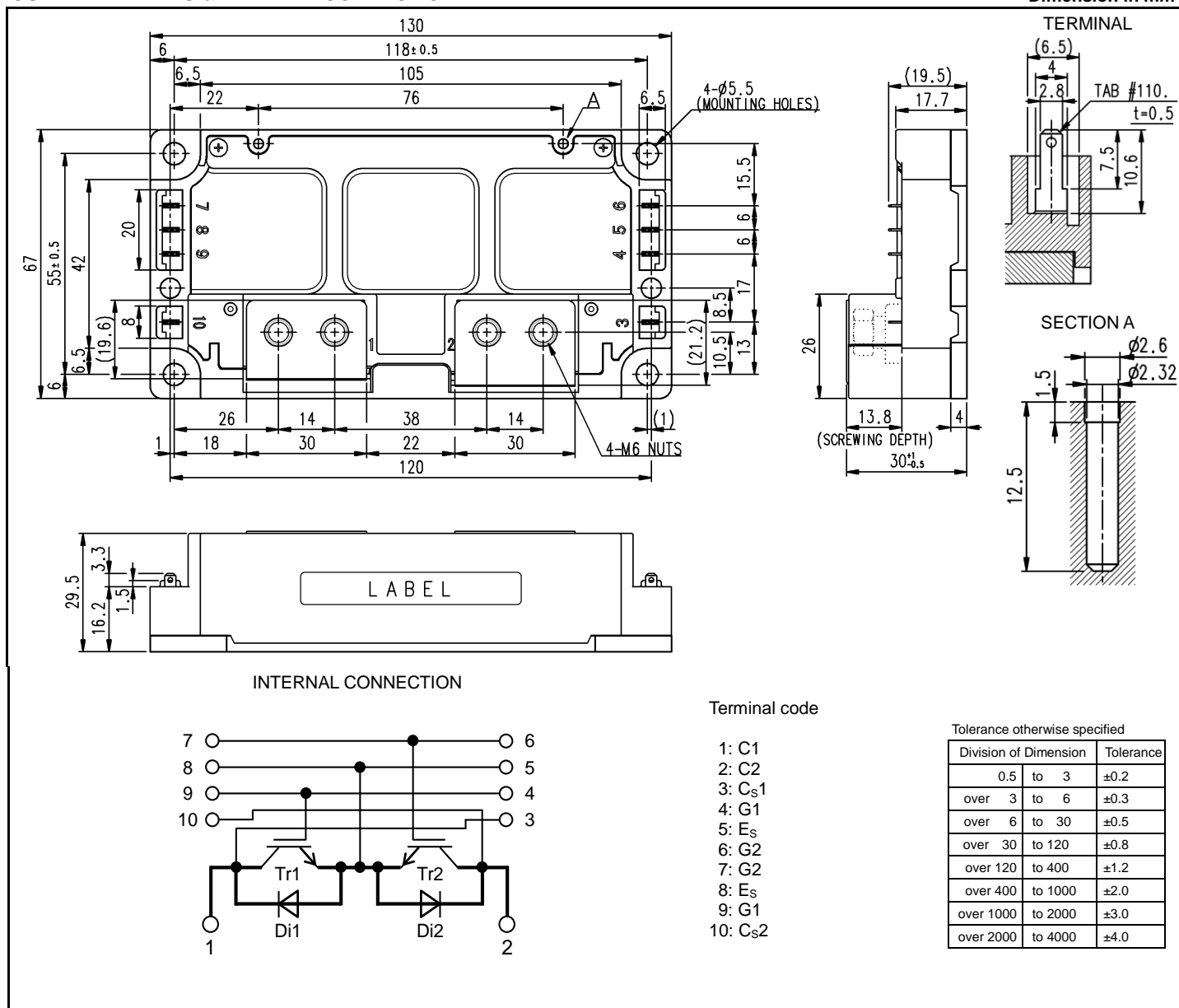
Collector current  $I_C$  ..... **5 0 0 A**  
 Collector-emitter voltage  $V_{CES}$  ..... **1 2 0 0 V**  
 Maximum junction temperature  $T_{vjmax}$  ..... **1 7 5 °C**

- Flat base Type
- Copper base plate
- Tin plating tab terminals
- RoHS Directive compliant
- Recognized under UL1557, File E323585

**APPLICATION**

AC Motor Control, Motion/Servo Control, Power supply, Photovoltaic power, Wind power, etc.

**OUTLINE DRAWING & INTERNAL CONNECTION**



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## MAXIMUM RATINGS (T<sub>vj</sub>=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Rating	Unit
V <sub>CES</sub>	Collector-emitter voltage	G-E short-circuited	1200	V
V <sub>GES</sub>	Gate-emitter voltage	C-E short-circuited	± 20	V
I <sub>C</sub>	Collector current	DC, T <sub>C</sub> =108 °C (Note2, 4)	500	A
I <sub>CRM</sub>		Pulse, Repetitive (Note3)	1000	
P <sub>tot</sub>	Total power dissipation	T <sub>C</sub> =25 °C (Note2, 4)	2880	W
I <sub>E</sub> (Note1)	Emitter current	DC (Note2)	500	A
I <sub>ERM</sub> (Note1)		Pulse, Repetitive (Note3)	1000	
V <sub>isol</sub>	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V
T <sub>vjmax</sub>	Maximum junction temperature	Instantaneous event (overload)	175	°C
T <sub>Cmax</sub>	Maximum case temperature	(Note4)	125	
T <sub>vjop</sub>	Operating junction temperature	Continuous operation (under switching)	-40 ~ +150	
T <sub>stg</sub>	Storage temperature	-	-40 ~ +125	

## ELECTRICAL CHARACTERISTICS (T<sub>vj</sub>=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
I <sub>CES</sub>	Collector-emitter cut-off current	V <sub>CE</sub> =V <sub>CES</sub> , G-E short-circuited	-	-	1.0	mA	
I <sub>GES</sub>	Gate-emitter leakage current	V <sub>GE</sub> =V <sub>GES</sub> , C-E short-circuited	-	-	0.5	µA	
V <sub>GE(th)</sub>	Gate-emitter threshold voltage	I <sub>C</sub> =50 mA, V <sub>CE</sub> =10 V	5.4	6.0	6.6	V	
V <sub>CEsat</sub> (Terminal)	Collector-emitter saturation voltage	I <sub>C</sub> =500 A, V <sub>GE</sub> =15 V, Refer to the figure of test circuit (Note5)	T <sub>vj</sub> =25 °C	-	1.80	2.25	V
V <sub>CEsat</sub> (Chip)			T <sub>vj</sub> =125 °C	-	2.00	-	
			T <sub>vj</sub> =150 °C	-	2.05	-	
	V <sub>CEsat</sub> (Chip)	I <sub>C</sub> =500 A, V <sub>GE</sub> =15 V, (Note5)	T <sub>vj</sub> =25 °C	-	1.70	2.15	V
T <sub>vj</sub> =125 °C			-	1.90	-		
T <sub>vj</sub> =150 °C			-	1.95	-		
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> =10 V, G-E short-circuited	-	-	50	nF	
C <sub>oes</sub>	Output capacitance		-	-	10		
C <sub>res</sub>	Reverse transfer capacitance		-	-	0.9		
Q <sub>G</sub>	Gate charge		V <sub>CC</sub> =600 V, I <sub>C</sub> =500 A, V <sub>GE</sub> =15 V	-	1.16		-
t <sub>d(on)</sub>	Turn-on delay time	V <sub>CC</sub> =600 V, I <sub>C</sub> =500 A, V <sub>GE</sub> =±15 V, R <sub>G</sub> =0 Ω, Inductive load	-	-	600	ns	
t <sub>r</sub>	Rise time		-	-	200		
t <sub>d(off)</sub>	Turn-off delay time		-	-	500		
t <sub>f</sub>	Fall time		-	-	200		
V <sub>EC</sub> (Note.1) (Terminal)	Emitter-collector voltage	I <sub>E</sub> =500 A, G-E short-circuited, Refer to the figure of test circuit (Note5)	T <sub>vj</sub> =25 °C	-	1.80	2.25	V
V <sub>EC</sub> (Note.1) (Chip)			T <sub>vj</sub> =125 °C	-	2.00	-	
			T <sub>vj</sub> =150 °C	-	2.05	-	
	V <sub>EC</sub> (Note.1) (Chip)	I <sub>E</sub> =500 A, G-E short-circuited, (Note5)	T <sub>vj</sub> =25 °C	-	1.70	2.15	V
T <sub>vj</sub> =125 °C			-	1.90	-		
T <sub>vj</sub> =150 °C			-	1.95	-		
t <sub>rr</sub> (Note1)	Reverse recovery time	V <sub>CC</sub> =600 V, I <sub>E</sub> =500 A, V <sub>GE</sub> =±15 V, R <sub>G</sub> =0 Ω, Inductive load	-	-	300	ns	
Q <sub>rr</sub> (Note1)	Reverse recovery charge	R <sub>G</sub> =0 Ω, Inductive load	-	60	-	µC	
E <sub>on</sub>	Turn-on switching energy per pulse	V <sub>CC</sub> =600 V, I <sub>C</sub> =I <sub>E</sub> =500 A, V <sub>GE</sub> =±15 V, R <sub>G</sub> =0 Ω, T <sub>vj</sub> =150 °C, Inductive load	-	66	-	mJ	
E <sub>off</sub>	Turn-off switching energy per pulse		-	54	-		
E <sub>rr</sub> (Note1)	Reverse recovery energy per pulse	Inductive load	-	41	-	mJ	
R <sub>CC'+EE'</sub>	Internal lead resistance	Main terminals-chip, per switch, T <sub>C</sub> =25 °C (Note4)	-	0.2	-	mΩ	
r <sub>g</sub>	Internal gate resistance	Per switch	-	5.5	-	Ω	

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## THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
$R_{th(j-c)Q}$	Thermal resistance	Junction to case, per IGBT (Note4)	-	-	52	K/kW
$R_{th(j-c)D}$		Junction to case, per FWD (Note4)	-	-	80	
$R_{th(c-s)}$	Contact thermal resistance	Case to heat sink, per 1 module, Thermal grease applied (Note4, 6)	-	18	-	K/kW

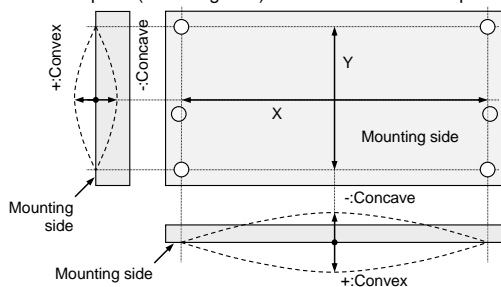
## MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
$M_t$	Mounting torque	Main terminals M 6 screw	3.5	4.0	4.5	N·m
$M_s$	Mounting torque	Mounting to heat sink M 5 screw	2.5	3.0	3.5	N·m
$d_s$	Creepage distance	Terminal to terminal	22.0	-	-	mm
		Terminal to base plate	21.9	-	-	
$d_a$	Clearance	Terminal to terminal	16.5	-	-	mm
		Terminal to base plate	12.5	-	-	
$e_c$	Flatness of base plate	On the centerline X, Y (Note7)	-50	-	+100	$\mu$ m
$m$	mass	-	-	490	-	g

\*: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

- Junction temperature ( $T_{vj}$ ) should not exceed  $T_{vjmax}$  rating.
- Pulse width and repetition rate should be such that the device junction temperature ( $T_{vj}$ ) dose not exceed  $T_{vjmax}$  rating.
- Case temperature ( $T_c$ ) and heat sink temperature ( $T_s$ ) are defined on the each surface (mounting side) of base plate and heat sink just under the chips.  
Refer to the figure of chip location.
- Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.
- Typical value is measured by using thermally conductive grease of  $\lambda=0.9$  W/(m·K)/ $D_{(c-s)}=100$   $\mu$ m.
- The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



- Use the following screws when mounting the printed circuit board (PCB) on the standoffs.

The length of the screw depends on the PCB thickness (t1.0).

Type	Size	Tightening torque	Recommended tightening method
(1) PT®	K25x8	$0.55 \pm 0.055$ N·m	by handwork (equivalent to 30 r/min by mechanical screw driver) ~ 600 r/min (by mechanical screw driver)
(2) PT®	K25x10	$0.85 \pm 0.085$ N·m	
(3) DELTA PT®	25x8	$0.55 \pm 0.055$ N·m	
(4) DELTA PT®	25x10	$0.85 \pm 0.085$ N·m	
(5) B1 tapping screw	$\phi 2.6 \times 10$ or $\phi 2.6 \times 12$	$0.85 \pm 0.085$ N·m	

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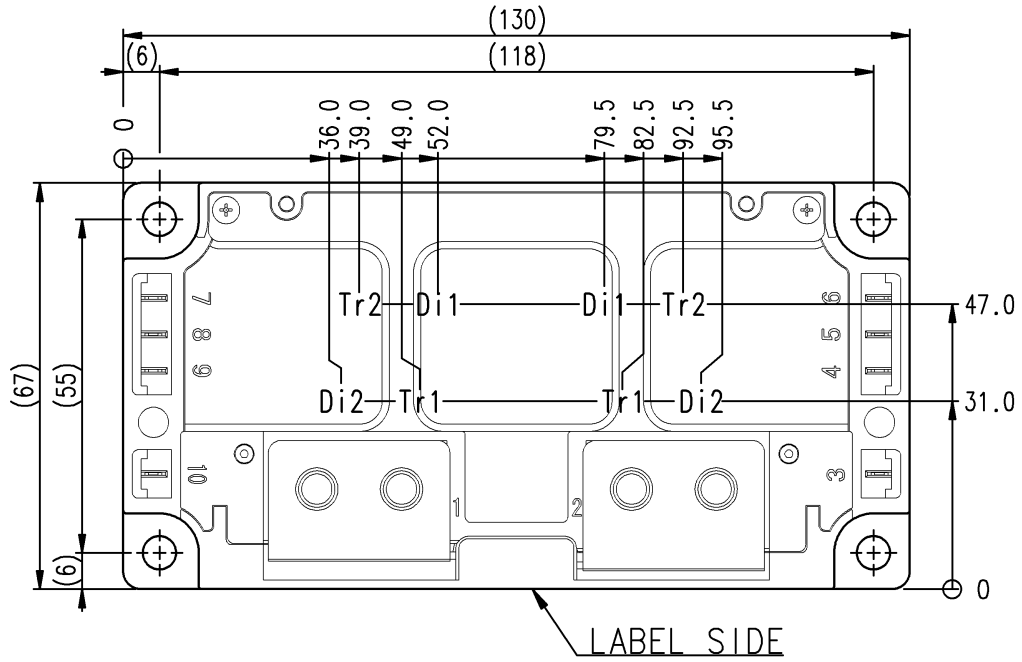
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## RECOMMENDED OPERATING CONDITIONS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
$V_{CC}$	(DC) Supply voltage	Applied across C1-E2 terminals	-	600	850	V
$V_{GEon}$	Gate (-emitter drive) voltage	Applied across G1-Es/ G2-Es terminals	13.5	15.0	16.5	V
$R_G$	External gate resistance	Per switch	0	-	15	$\Omega$

### CHIP LOCATION (Top view)

Dimension in mm, tolerance:  $\pm 1$  mm

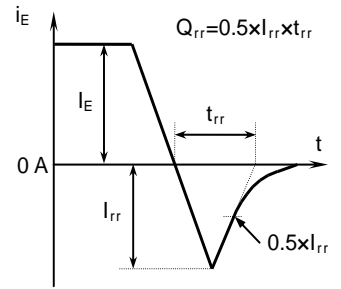
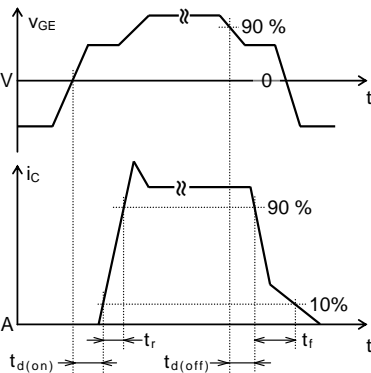
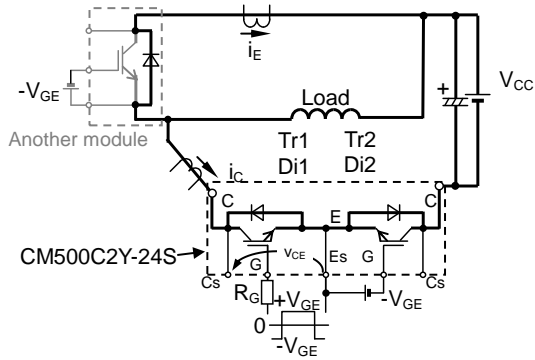


Tr1/Tr2: IGBT, Di1/Di2: FWD

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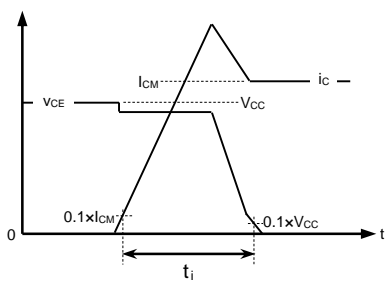
HIGH POWER SWITCHING USE  
INSULATED TYPE

## TEST CIRCUIT AND WAVEFORMS

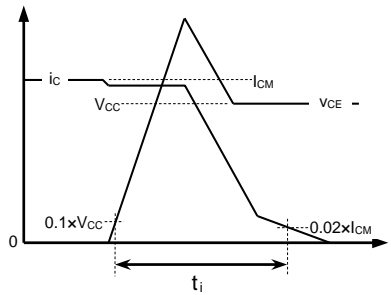


Switching characteristics test circuit and waveforms

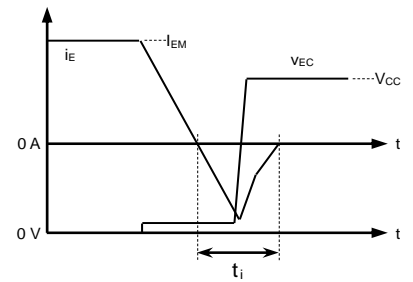
$t_{rr}$ ,  $Q_{rr}$  characteristics test waveform



IGBT Turn-on switching energy



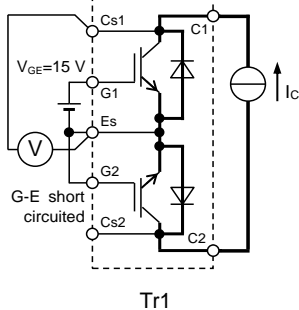
IGBT Turn-off switching energy



FWD Reverse recovery energy

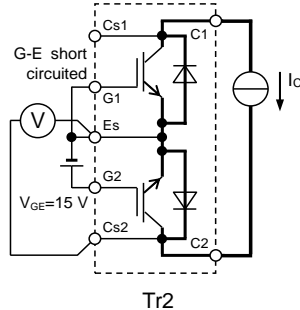
Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

## TEST CIRCUIT

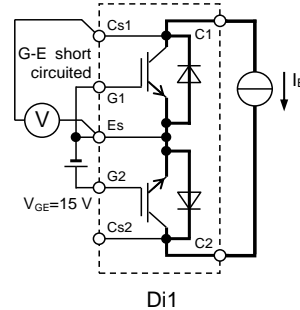


Tr1

$V_{CEsat}$  characteristics test circuit

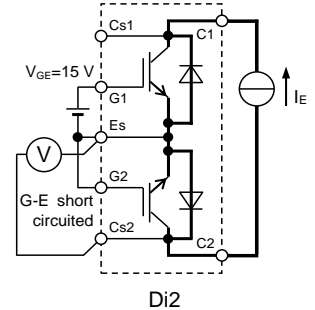


Tr2



Di1

$V_{CE}$  characteristics test circuit



Di2

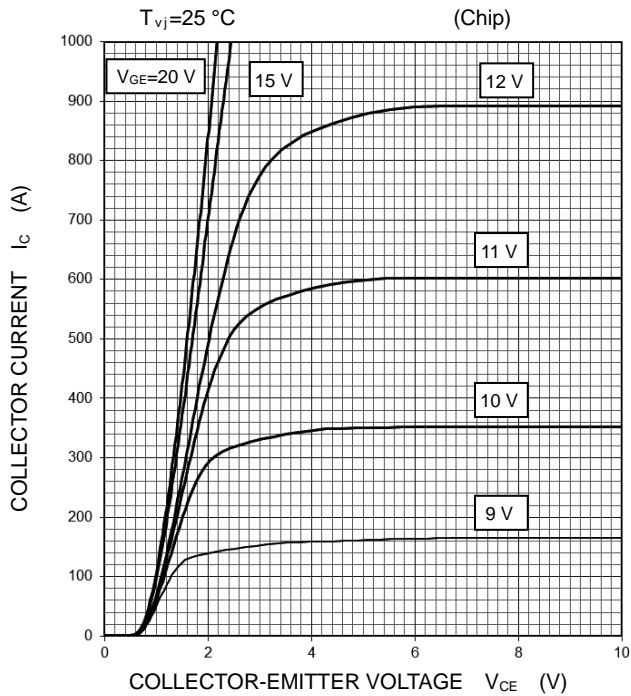
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## PERFORMANCE CURVES

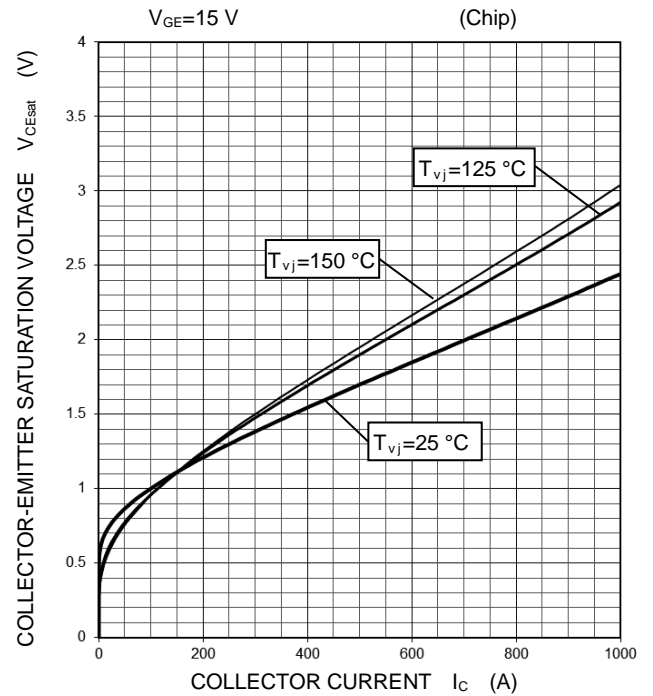
OUTPUT CHARACTERISTICS

(TYPICAL)



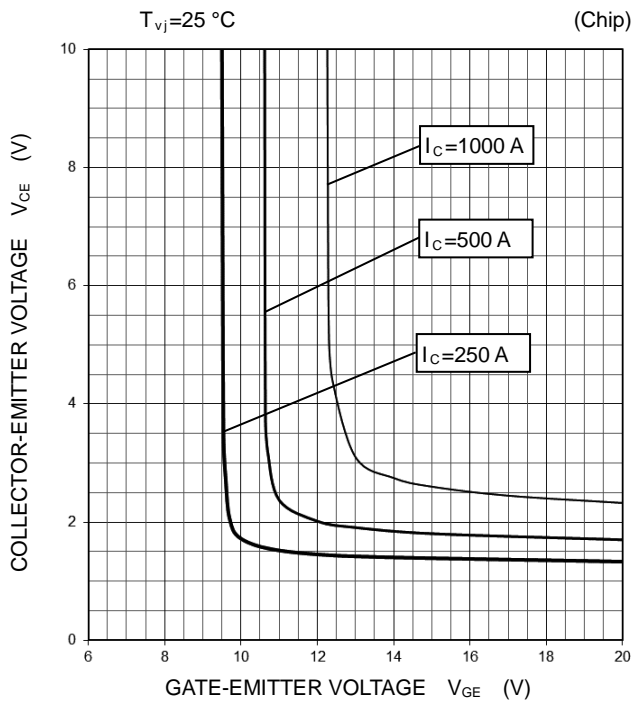
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS

(TYPICAL)



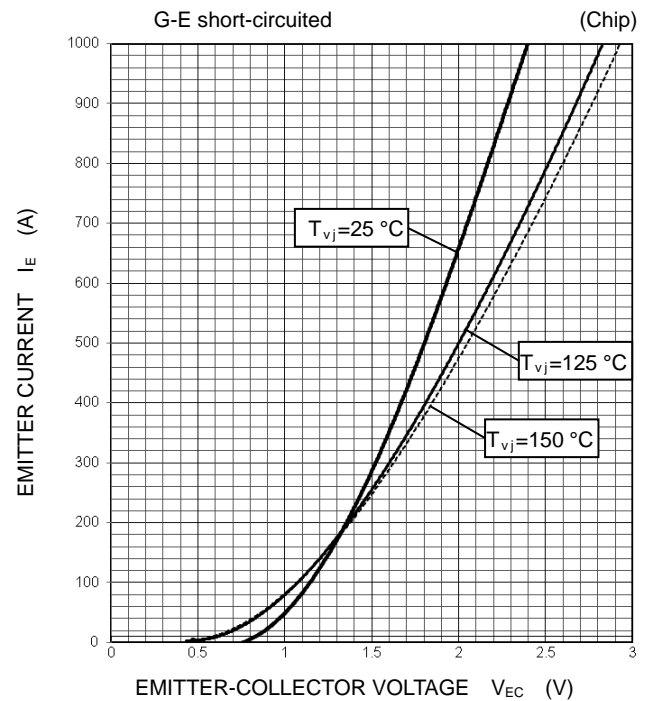
COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS

(TYPICAL)



FREE WHEELING DIODE FORWARD CHARACTERISTICS

(TYPICAL)



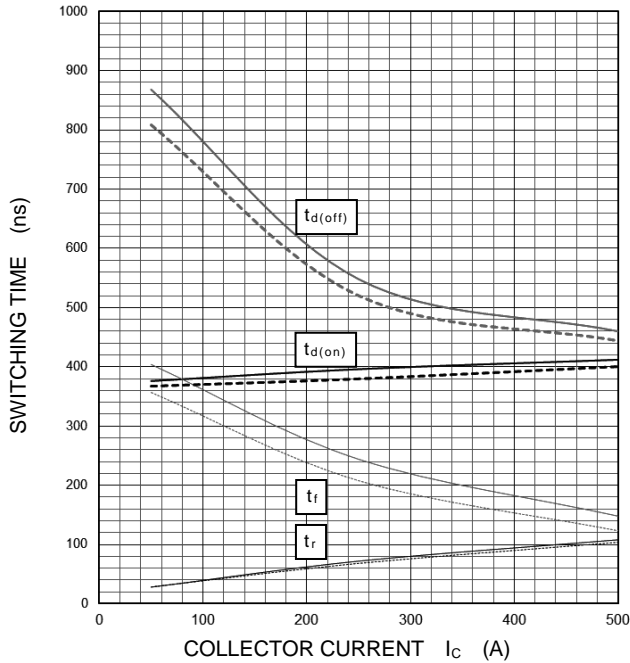
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## PERFORMANCE CURVES

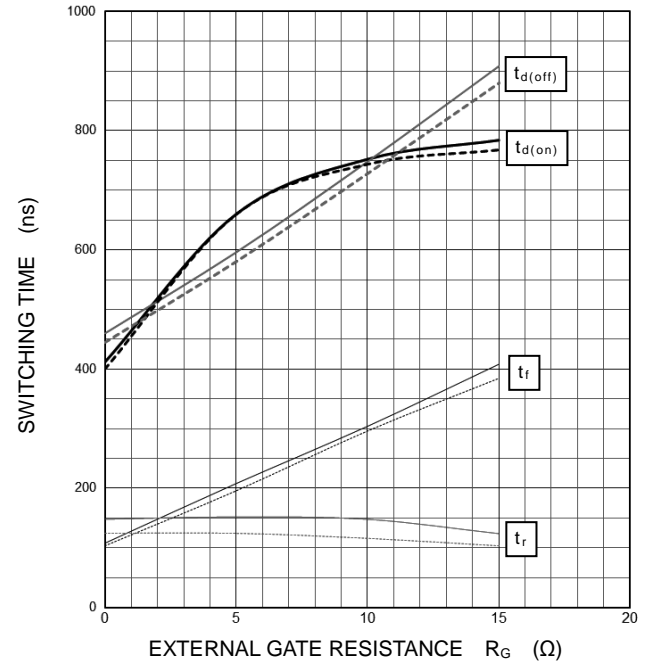
**HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)**

$V_{CC}=600\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $R_G=0\ \Omega$ , INDUCTIVE LOAD  
 —:  $T_{vj}=150\text{ }^\circ\text{C}$ , - - - -:  $T_{vj}=125\text{ }^\circ\text{C}$



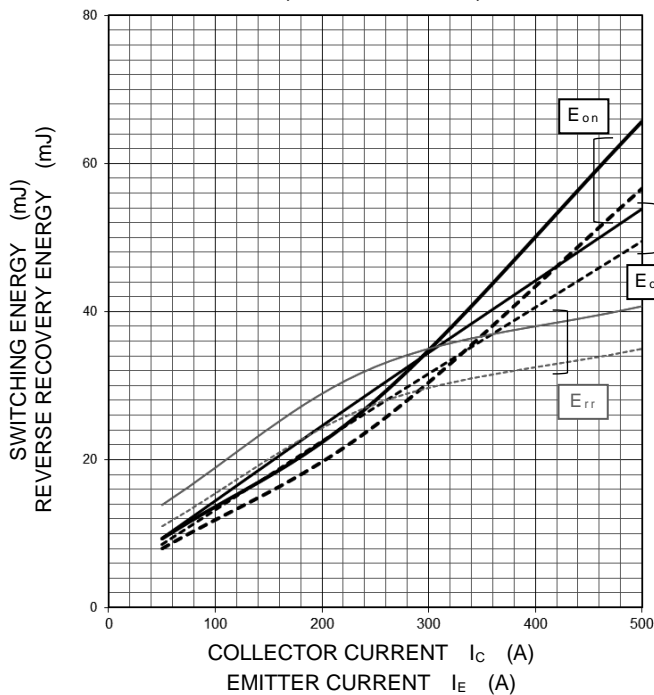
**HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)**

$V_{CC}=600\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $I_C=500\text{ A}$ , INDUCTIVE LOAD  
 —:  $T_{vj}=150\text{ }^\circ\text{C}$ , - - - -:  $T_{vj}=125\text{ }^\circ\text{C}$



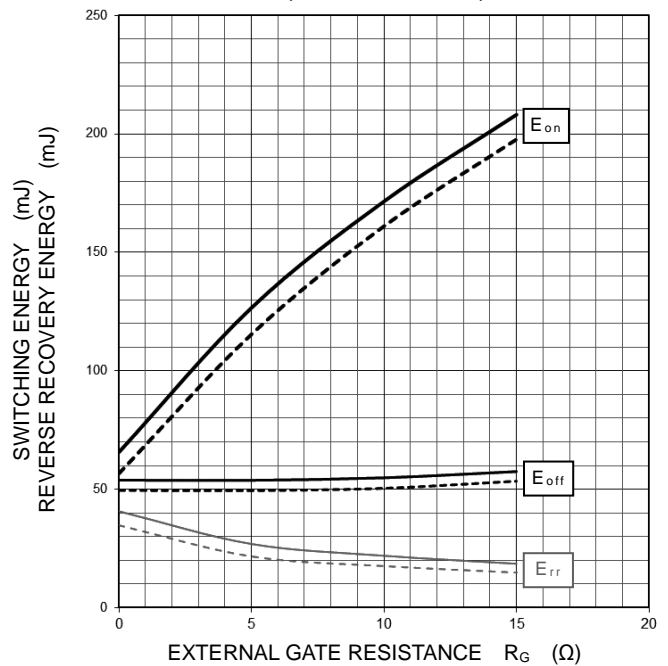
**HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)**

$V_{CC}=600\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $R_G=0\ \Omega$ ,  
INDUCTIVE LOAD, PER PULSE  
 —:  $T_{vj}=150\text{ }^\circ\text{C}$ , - - - -:  $T_{vj}=125\text{ }^\circ\text{C}$



**HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)**

$V_{CC}=600\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $I_C/I_E=500\text{ A}$ ,  
INDUCTIVE LOAD, PER PULSE  
 —:  $T_{vj}=150\text{ }^\circ\text{C}$ , - - - -:  $T_{vj}=125\text{ }^\circ\text{C}$



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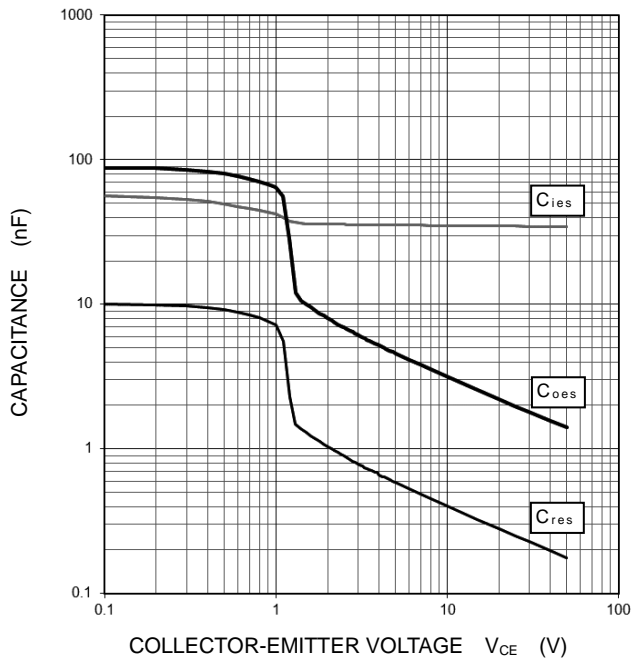
HIGH POWER SWITCHING USE  
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## PERFORMANCE CURVES

### CAPACITANCE CHARACTERISTICS

(TYPICAL)

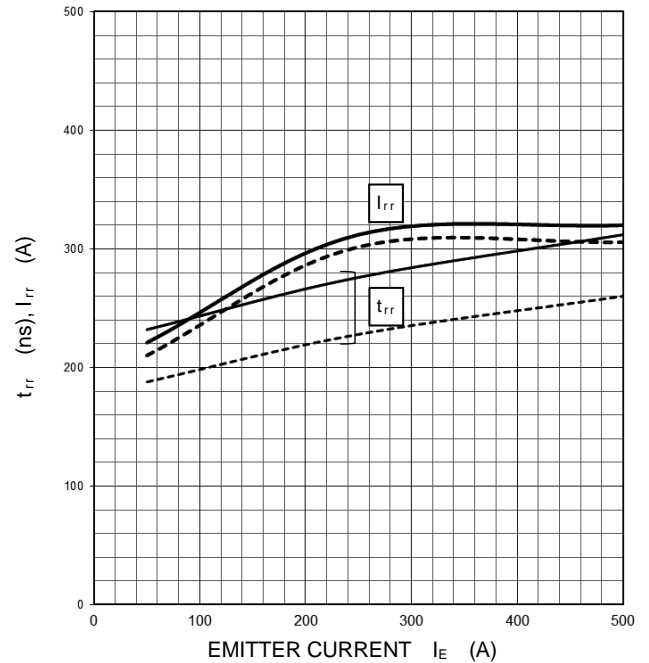
G-E short-circuited,  $T_{vj}=25\text{ }^{\circ}\text{C}$



### FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS

(TYPICAL)

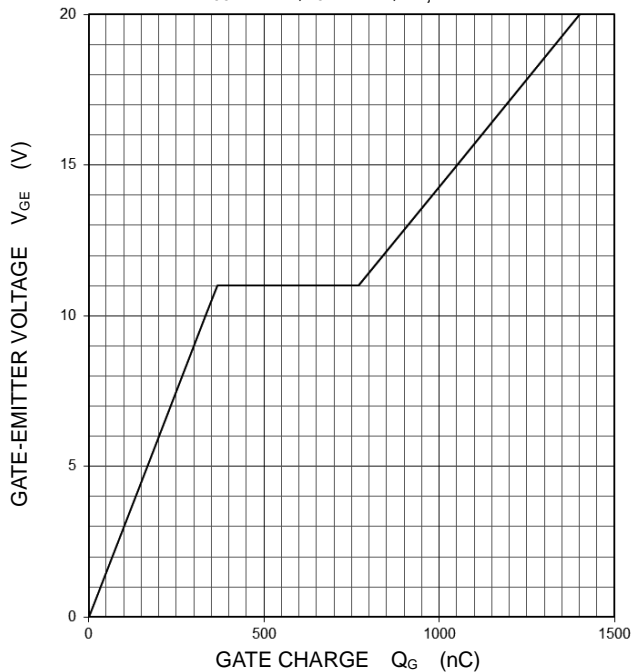
$V_{CC}=600\text{ V}$ ,  $V_{GE}=\pm 15\text{ V}$ ,  $R_G=0\ \Omega$ , INDUCTIVE LOAD  
 —:  $T_{vj}=150\text{ }^{\circ}\text{C}$ , - - - -:  $T_{vj}=125\text{ }^{\circ}\text{C}$



### GATE CHARGE CHARACTERISTICS

(TYPICAL)

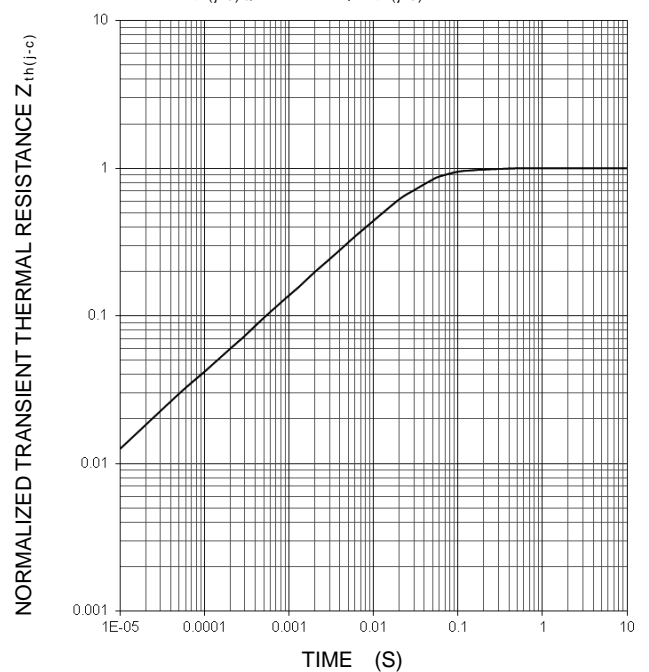
$V_{CC}=600\text{ V}$ ,  $I_C=500\text{ A}$ ,  $T_{vj}=25\text{ }^{\circ}\text{C}$



### TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS

(MAXIMUM)

Single pulse,  $T_C=25\text{ }^{\circ}\text{C}$   
 $R_{th(j-c)Q}=52\text{ K/kW}$ ,  $R_{th(j-c)D}=80\text{ K/kW}$



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



### **Keep safety first in your circuit designs!**

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